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da Silva Padilha, Giovana; Mansanares Giacon, Virginia; Bartoli, Julio Roberto
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Effect of Plasma Fluorination Variables on the Deposition and Growth of Partially Fluorinated Polymer Over PMMA Films

Giovana da Silva Padilha

School of Food Engineering, State University of Campinas – UNICAMP

Virginia Mansanares Giacon

Federal University of Amazonas – UFAM

Julio Roberto Bartoli

School of Chemical Engineering, State University of Campinas – UNICAMP

Abstract: In this work, an investigation was made of the modification of film surface of Poly(methylmethacrylate) (PMMA) using the plasma polymerization technique. PMMA films 10 μm thick were obtained by Spin-Coating starting from a chloroform solution (15.36% w/w). The films were exposed to the plasma of CHF_3 at different gas pressures and exposure times to increase the thickness of fluorinated polymers onto PMMA films. The plasma fluorinated optical films were characterized by gravimetry, FTIR-ATR, contact angle of wetting, SEM and AFM. The surface fluorination of PMMA films can be inferred by the increase in contact angle under all experimental conditions, and confirmed with FTIR-ATR analysis. Gravimetry showed an increase of the fluorinated polymer layer over PMMA films, being 1.55 μm thick at 0.7 torr and 40 minutes of plasma exposure. The SEM analysis showed a well-defined layer of fluorinated polymer, with fluorine being detected in the EDS analysis. The film roughness for the fluorinated polymers was around of 200 Å, quite satisfactory for a 1.55 μm cladding.

Keywords: PMMA, plasma fluorination, CHF_3 gas.

Introduction

PMMA has been extensively studied for the numerous applications in the field of coatings, adhesives, sensors, optical devices, biomaterials. PMMA can be deposited by many techniques as plasma polymerization, thermal deposition, RF sputtering, etc.^[1,2] In optical devices, PMMA shows the best optical properties among transparent polymers, being a very common core material in polymeric optical fibers, waveguides and optical interconnect^[3]. For this, the use of polymers have been studied due to the intrinsic versatility molecular structure that allows advantageous refractive index modeling for core and cladding, and also to their easy fabrication process or patterning capability^[4,5]. Low refractive index is a requirement for cladding material and it is usually achieved with fluorinated polymers. Plasma polymerization is the most efficient methods of surface modification, being studied for last one and a half decade. They have yet not been thoroughly explored. Since, polymer tends to react distinctly with each surface modification technique it leaves a wide scope for in-depth explorations and novel applications^[6,7]. Plasma of fluorocarbons has unique capability to etch several inorganic and organic materials as well as to deposit fluoropolymer thin films. The intrinsic versatility of these plasmas reflects their ability to generate two kinds of reactive species, namely fluor atoms and CF_x ($x = 1, 2$ and 3) fragments, which are responsible of the etching

of many substrates and of the deposition of a wide range of fluorocarbon coatings^[8]. Previous work showed the feasibility to use the plasma fluorination process to modify the surface and reduce the refractive index of PMMA films. XPS and FTIR-ATR analysis revealed that a thin layer of a partially fluorinated polymer was deposited on the PMMA films after plasma^[9]. In this work, plasma fluorinated PMMA optical films were produced by CHF_3 plasma. The plasma process variables, gas pressure and exposition time, were explored to achieve increased thicker fluorinated layer onto PMMA films.

Methodology

PMMA (Plexiglas V052, *Rohm and Haas*) films were prepared by spin coating (*Headway Research*, at 1900 rpm and 30s) onto a silicon substrate using a solution of PMMA and chloroform^[10] (15.36% w/w). PMMA film thicknesses were around 10 μm . The PMMA films were exposed to CHF_3 gas plasma in a parallel plate reactor (*ENIRF*) connected to a radio-frequency generator (13.56 MHz). 2^2 Star Factorial Experimental Design^[11] (Table 1), with axial levels ($\sqrt{2}$) and central point, was used to verify the linear or quadratic effect of the plasma variables, gas pressure and time, on the thickness of the plasma deposited polymer. Eleven experiments were carried out with triplicate at the

Table 1. Factors and levels for CHF₃ plasma processing.

	- α (-1,42)	Lowest level (-1)	Central point (0)	Upper level (+1)	+ α (+1,42)
Pressure (torr)	0.217	0.3	0.5	0.7	0.783
Time (min)	15.86	20	30	40	44.14

central point of the star design. Plasma power and gas flow rate were kept at 120 W and 20 sccm, respectively.

The surfaces of the polymeric films, before and after plasma, were characterized using the following techniques:

- FTIR-ATR analysis (Bruker Equinox 55, ATR-PIKE MIRacle with zinc selenate (ZnSe) crystal, 45° angle, 32 scans);
- Contact angle measurements of surface wetting (*Tantec Half-Angle CAM-MICRO*), using water as contact liquid at non-saturated conditions (22 °C, H.R. 60%);
- Gravimetry (10⁻⁵ g precision), to estimate thickness of the fluorinated layer on the PMMA films after plasma, using density of known partially fluorinated polymer (PVDF: d = 1.75-1.80 g/cm³)^[12];
- Scanning electron microscopy (SEM) with Energy dispersive spectroscopy probe (EDS) (*LEO 440i*);
- Atomic force microscopy (AFM) (*AutoProbe CPII*).

Results and Discussion

Polymerization rate may be efficient at high pressures and processing time, this planning was made increasing by some points the gas discharge pressure and time^[12]. The statistical analysis showed that the process variables pressure and time were significant at 95% confidence (Equation 1).

$$\text{thickness} = 0.58 + 0.28 \times X_1 + 0.004 \times X_1^2 + 0.29 \times X_2 + 0.07 \times X_2^2 + 0.08 \times X_1 \times X_2 \quad (1)$$

As the quadratic terms were not significant, as well as the interaction between pressure and time, the Equation 1 was simplified to Equation 2:

$$\text{thickness} = 0.64 + 0.28 \times X_1 + 0.29 \times X_2 \quad (2)$$

$$\text{In which: } X_1 = \frac{\text{pressure} - 0.5}{0.2} \text{ and } X_2 = \frac{\text{time} - 30}{10}.$$

The contact angle measurements in the PMMA surface was 72.0 ± 2°. The increase of the contact angle values after plasma processing showed surfaces similar to PTFE (polytetrafluoroethylene - angle 110°)^[13]. However, there weren't significant differences at 95% confidence at the process conditions investigated. Table 2 shows the results of the mass, thickness and contact angle measurements in the layer deposited by plasma over PMMA films in different process conditions.

Further FTIR-ATR analyses indicated a change concerning the molecular groups of PMMA regarding the fluorinated films. Figure 1 shows the changes involved with different processing times at pressures of 0.5 torr with time variation and Figure 2 shows the changes at different gas discharge pressures within 30 minutes

Table 2. Mass, thickness and contact angles after fluorination processes.

Process conditions		Mass (mg)	Thickness (m)	Contact Angle (°)
Pressure (torr)	Time (min)			
0.783	30	0.97	0.85	109.6
0.7	40	2.00	1.59	104.6
0.7	20	0.73	0.61	102.0
0.5	44.14	0.67	0.89	110.0
0.5	30	0.85	0.67	108.0
0.5	30	0.60	0.68	109.6
0.5	30	0.62	0.45	113.6
0.5	15.86	0.46	0.38	113.6
0.3	40	0.58	0.79	109.0
0.3	20	0.17	0.14	102.0
0.217	30	0.16	0.15	109.0

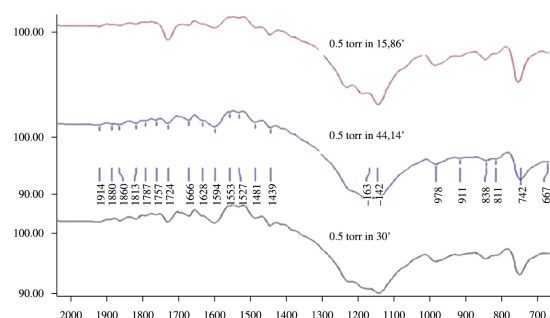


Figure 1. FTIR-ATR spectrums of fluorinated samples (plasma of 0.5 torr in 15.86, 44.14 and 30 minutes).

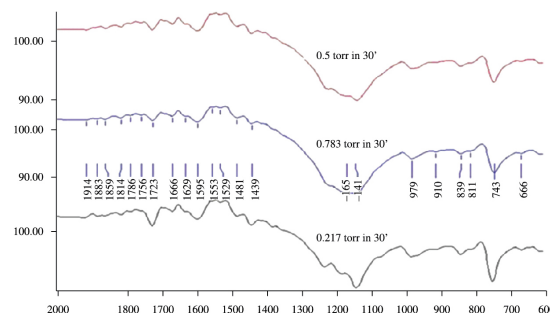


Figure 2. FTIR-ATR spectrums of fluorinated samples (plasma of 0.5, 0.783 and 0.217 torr in 30 minutes).

processing time with pressure variation. For this characterization, the analyses deepness was estimated in 1.14 μm and 1.72 μm at 1721 cm⁻¹ and 1137 cm⁻¹, respectively. The absorption bands showed up between 980 cm⁻¹ and 1450 cm⁻¹, characteristic of the species CF_x. Favia et al.^[14] studied FTIR transmittance spectra of films deposited in different conditions and saw sharp

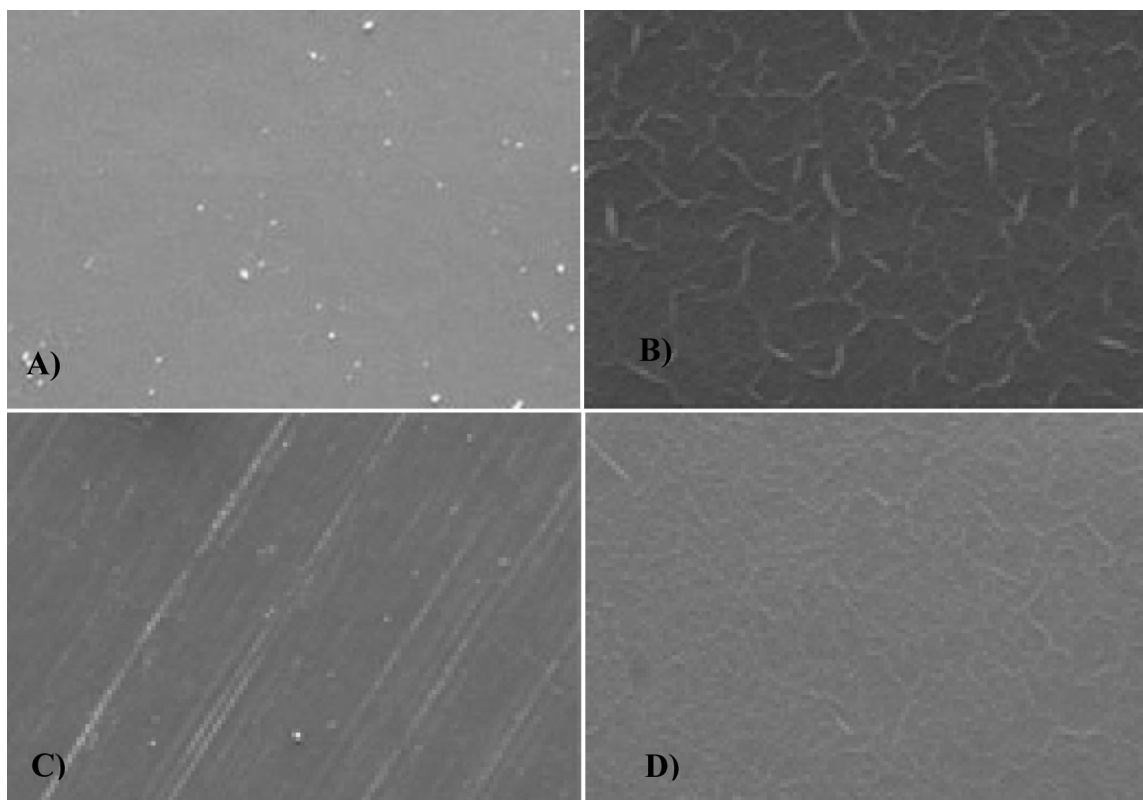


Figure 3. SEM of film surface, with enlargement of 5000x; A) original PMMA and B) 0.783 torr and 30 minutes, C) 0.7 torr and 40 minutes, D) 0.5 torr and 44.14 minutes.

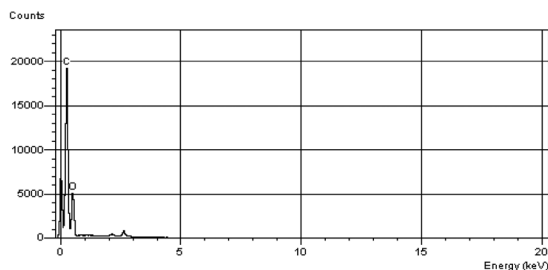


Figure 4. EDS analyses at the central region of a PMMA film.

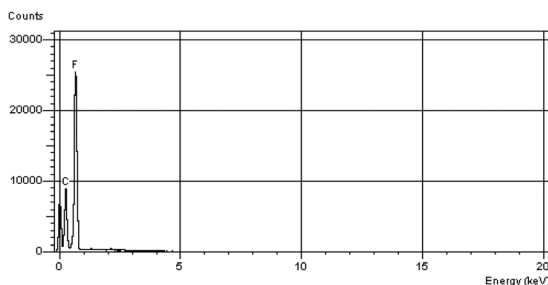


Figure 5. EDS analyses at the central region of a sample after treatment by plasma (0.783 torr and 30 minutes).

absorption band at approximately 1180 cm^{-1} due species CF_2 . While Bartoli et al.^[9] observed a reduction in the relative intensity of the CH_2 absorption bands at 1485 cm^{-1} after treatment by plasma, and also a shift to 1390 cm^{-1} , after 10 minutes by plasma. After plasma treatment, the

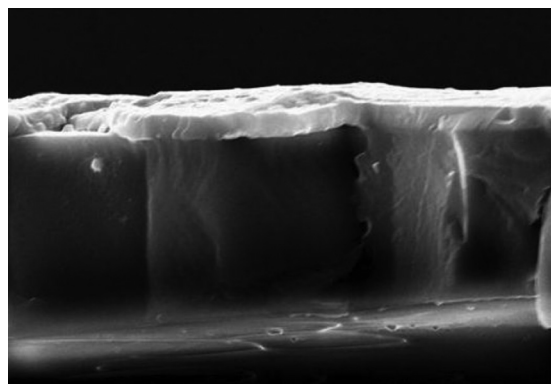


Figure 6. SEM of the cross-section of a sample at process conditions 0.783 torr in 30 minutes.

spectrum of initial PMMA date with the line at 1730 cm^{-1} attributed to $\nu(\text{C}=\text{O})$ vibration wasn't significant^[15].

By scanning electron microscopy (SEM) it was possible to learn about the surface topography. Figure 3A shows the surface of the PMMA polymeric film over the silicon substrate, it was possible see no irregularity during the formation of the polymeric film. Figures 3B-D show the morphology of the fluorinated surfaces at process conditions of 0.783 torr and 30 minutes, 0.7 torr and 40 minutes and 0.5 torr and 44.14 minutes, respectively. Significant morphological changes are present. The morphological built up over the PMMA films may be associated to the plasma reactor conditions.

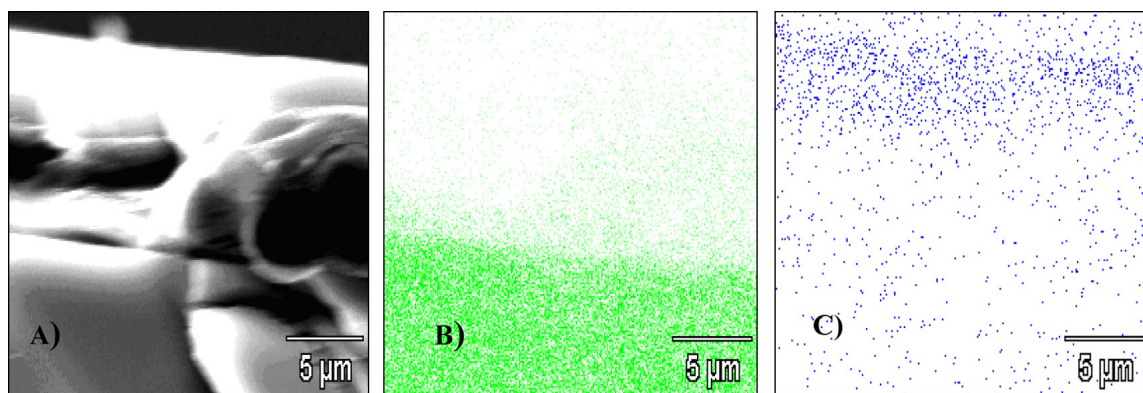


Figure 7. A) SEM of cross-section of a sample which indicate the presence of: B) silicon; C) fluor.

By EDS technique it was possible to observe the chemical characterization of the elements present in the PMMA film and in the fluorinated film. Figure 4 shows the presence of carbon and oxygen on the surface of PMMA films. Fluorinated treatment was confirmed by Figure 5 in which the presence of fluor on the surface of the layer treated by plasma (0.783 torr in 30 minutes), which does not occur on the surface of the PMMA film. This was observed at distinct points of several samples at some process conditions, in which fluor was always present followed by carbon. The absence of oxygen indicates the total coating of the PMMA layer by fluorinated layer.

To see the layers produced over the silicon substrate, cross-sectional cuts were made in a few samples. Figure 6 shows the composition of the PMMA film and the fluorinated film at process conditions of 0.783 torr in 30 minutes, at the sample center region. The darkest shades are due to a higher concentration of light chemical elements, as carbon and oxygen. As fluor is heavier, the upper layer presented a clearer region.

Using the EDS probe, the mapping by X-ray was carried out, in order to obtain qualitative information about the elements present in the sample produced in the processing condition of 0.7 torr in 40 minutes. Figure 7a shows the cross-section of the sample submitted to the analysis. From this image it was possible to recognize the elements present in the substrate, PMMA film and fluorinated film. Figure 7b, c show the presence the silicon and fluor, respectively. As expected, in the interior region, silicon is in greater proportion for it is a region in which the substrate is present, and fluor is in greater proportion in the upper region, which is a layer deposited by a fluorinated polymer.

The AFM technique was used to check the roughness of the polymeric film after plasma treatment. Figure 8 shows some structures developed from convection cells to PMMA film. By this image it was possible to note a major distance between peaks and valleys (~297 nm); the *rms* roughness obtained by this technique was 40 nm. Figure 9 shows the fluorinated film by plasma at process condition of 0.7 torr in 40 minutes which presented the greatest thickness by gravimetry: 1.55 µm. It is still observed the convection cells produced during the formation of film by *spin-coating*. This might indicate that the fluorinated layer deposited on the PMMA is

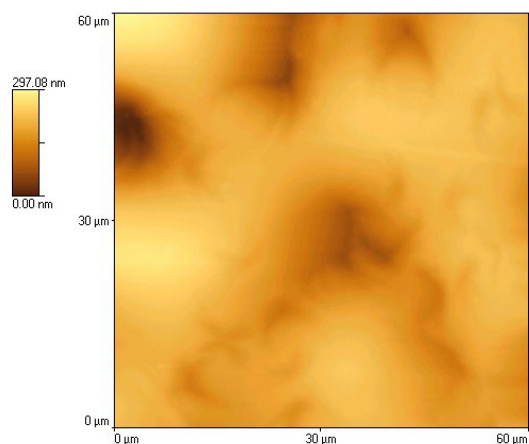


Figure 8. AFM analysis for the PMMA film prepared by *spin-coating*. The *rms* roughness for this image was 400 Å. The analysis area was 60 × 60 µm.

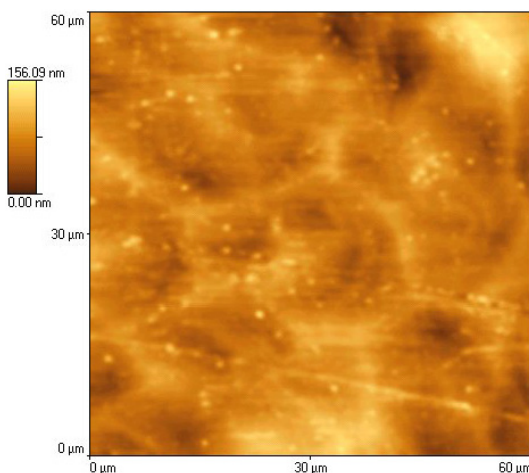


Figure 9. AFM analysis for the fluorinated film prepared at 0.7 torr in 40 minutes. The *rms* roughness for this image was 400 Å. The analysis area was 60 × 60 µm.

transparent (characteristic of amorphous polymers), which allows observation of the cells. But even with the formations there are reduction on the distance between peaks and valleys (~156 nm). For this sample, the *rms*

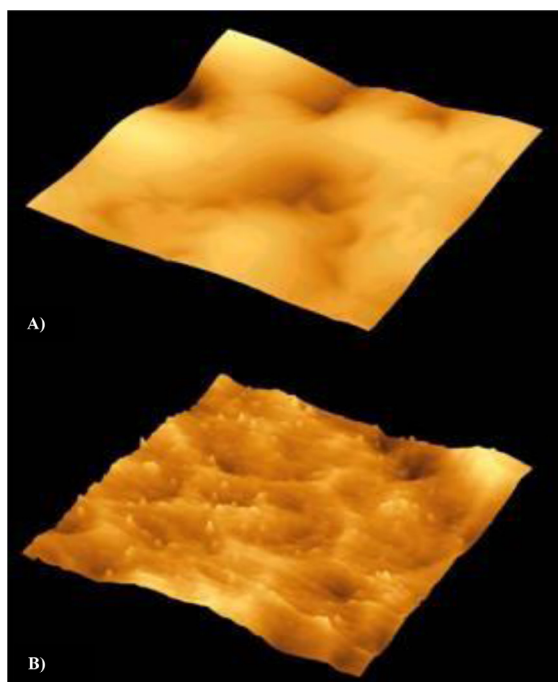


Figure 10. Tridimensional image of the AFM analysis: A) PMMA film – *rms* roughness of 400 Å; B) fluorinated film at process condition 0.7 torr in 40 minutes – *rms* roughness of 200Å.

roughness was 20 nm, i.e., half the value of the original PMMA films. Tridimensional images (3D) of the films are presented in Figure 10a (PMMA film) and Figure 10b (fluorinated film), confirming the morphological change of the films surface.

The roughness obtained in this work for the fluorinated sample (20 nm) may be acceptable for film 1.5 µm ticks, exhibiting a ratio of 1/70 for the roughness/thickness ratio. This is well satisfactory for the construction of a waveguide^[9]. This paper shown that the plasma treatment is effective in altering the functional groups of polymer surfaces without affecting the bulk properties^[5].

Conclusion

PMMA films after exposition to CHF_3 showed a significant increase in the contact angle values of the modified surface. The FTIR-ATR analyses indicated a change in the absorption bands typical of PMMA: C = O and C-O, when compared to fluorinated films. This change may be associated to the presence of fluor atoms or to a polymer partially fluorinated over PMMA surface. The objective to reach higher thickness of the fluorinated

layer on the PMMA film was reached. Fluorinated films 1.55 µm tick can be employed for cladding in waveguides or polymeric optical fibers. By SEM the microstructures on the fluorinated film surface were observed, proving the presence of fluor on the surface of the films treated by plasma observing the cross-section. The AFM showed the reduction of the roughness of the optical films after plasma treatment compared with the original PMMA films. These results indicate the possibility of modifying the PMMA surface by deposition of a partially fluorinated polymeric layer with adequate thickness using CHF_3 plasma.

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